Supporting Information

Ternary Asymmetric Particles with Controllable Patchiness

Zhiyuan Zhao, Zengmin Shi, Ye Yu, and Gang Zhang*

State Key Lab of Supramolecular Structure and Materials, College of Chemistry, Jilin University,

Changchun 130012, P.R. China.

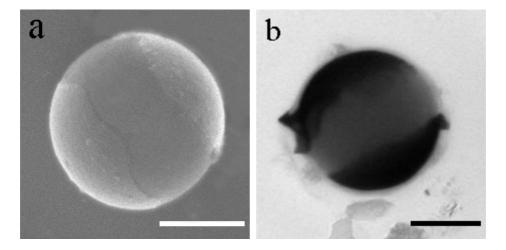


Figure S1 SEM (a) and TEM (b) image of the ternary asymmetric particles modified by Au and Ni via double-sided etching and modifying method after annealing at 500 $^{\circ}$ C. Scale bars: 1.0 μ m.

_

^{*}Corresponding Author. E-mail: gang@jlu.edu.cn.

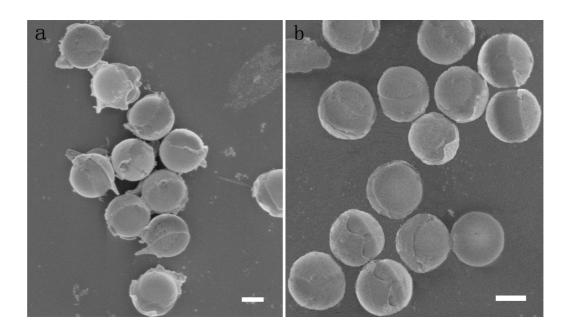


Figure S2 SEM images of the ternary asymmetric particles structure modified with Au via double-modifying and peeling off, release on another substrate, and shown (a) before annealing with overhang and (b) without overhang after annealing at 500 °C. Scale bars: $1.0 \, \mu m$.

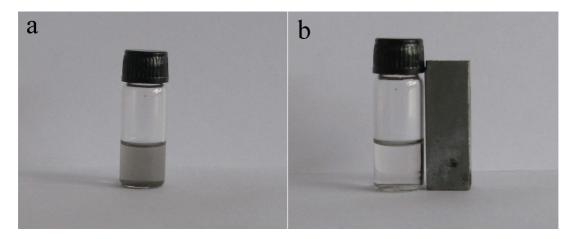


Figure S3 Photographs of the ternary asymmetric particles modified using Au and Ni (A) without magnetic field, (B) with magnetic field.